

QIAOXIN N-Channel Super Trench Power MOSFET

Description

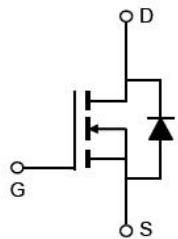
The VCRRP02515K uses **Super Trench** technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{DS(ON)}$ and Q_g . This device is ideal for high-frequency switching and synchronous rectification.

General Features

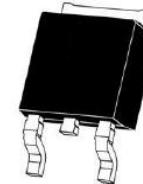
- $V_{DS} = 250V, I_D = 15A$
- $R_{DS(ON)} = 200m\Omega$ (typical) @ $V_{GS} = 10V$
- Excellent gate charge $\times R_{DS(on)}$ product(FOM)
- Very low on-resistance $R_{DS(on)}$
- 175 °C operating temperature
- Pb-free lead plating

Application

- LED backlighting
- Ideal for high-frequency switching and synchronous rectification



Schematic diagram



TO-252 -2Ltop view

Package Marking and Ordering Information

Device Marking	Device	Device Package
VCRRP02515K		TO-252-2L

Absolute Maximum Ratings ($T_A=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	250	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous	I_D	15	A
Drain Current-Continuous($T_c=100^\circ C$)	$I_D (100^\circ C)$	10.6	A
Pulsed Drain Current	I_{DM}	60	A
Maximum Power Dissipation	P_D	140	W
Derating factor		0.93	W/°C
Single pulse avalanche energy (Note 1)	E_{AS}	80	mJ
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 175	°C

Thermal Characteristic

Thermal Résistance, Junction-to-Case	$R_{\theta JC}$	1.1	°C/W
--------------------------------------	-----------------	-----	------

Electrical Characteristics ($T_A=25^\circ\text{C}$ unless otherwise noted)

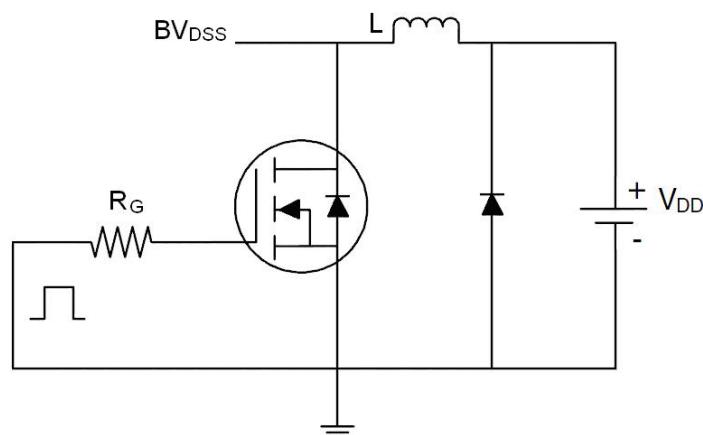
Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	250	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}}=250\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
On Characteristics						
Gate Threshold Voltage	$V_{\text{GS(th)}}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.5	3.5	4.5	V
Drain-Source On-State Resistance	$R_{\text{DS(ON)}}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=7.5\text{A}$	-	200	250	$\text{m}\Omega$
Gate resistance	R_{G}		-	4.5	-	Ω
Forward Transconductance	g_{FS}	$V_{\text{DS}}=5\text{V}, I_{\text{D}}=15\text{A}$	15	-	-	S
Dynamic Characteristics						
Input Capacitance	C_{iss}	$V_{\text{DS}}=125\text{V}, V_{\text{GS}}=0\text{V}, F=1.0\text{MHz}$	-	475		PF
Output Capacitance	C_{oss}		-	34		PF
Reverse Transfer Capacitance	C_{rss}		-	1.2		PF
Switching Characteristics (Note 2)						
Turn-on Delay Time	$t_{\text{d(on)}}$	$V_{\text{DD}}=125\text{V}, R_{\text{L}}=8\Omega$ $V_{\text{GS}}=10\text{V}, R_{\text{G}}=3\Omega$	-	4	-	nS
Turn-on Rise Time	t_{r}		-	5	-	nS
Turn-Off Delay Time	$t_{\text{d(off)}}$		-	10	-	nS
Turn-Off Fall Time	t_{f}		-	2	-	nS
Total Gate Charge	Q_{g}	$V_{\text{DS}}=125\text{V}, I_{\text{D}}=15\text{A}, V_{\text{GS}}=10\text{V}$	-	8.9	-	nC
Gate-Source Charge	Q_{gs}		-	3.3	-	nC
Gate-Drain Charge	Q_{gd}		-	2.5	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage	V_{SD}	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=15\text{A}$	-	-	1.2	V
Diode Forward Current	I_{S}		-	-	15	A
Reverse Recovery Time	t_{rr}	$T_{\text{J}} = 25^\circ\text{C}, I_{\text{F}} = I_{\text{S}}$ $di/dt = 100\text{A}/\mu\text{s}$	-	25	-	nS
Reverse Recovery Charge	Q_{rr}		-	110	-	nC

Notes:

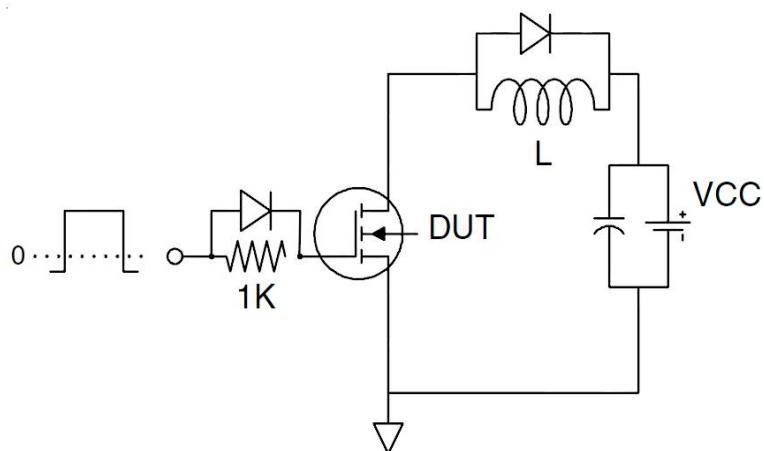
- EAS condition : $T_{\text{J}}=25^\circ\text{C}, V_{\text{DD}}=50\text{V}, V_{\text{G}}=10\text{V}, L=0.5\text{mH}, R_{\text{G}}=25\Omega$
- Guaranteed by design, not subject to production
- These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink k , assuming a maximum junction temperature of $T_{\text{J(MAX)}}=175^\circ\text{C}$. The SOA curve provides a single pulse rating.

Test Circuit

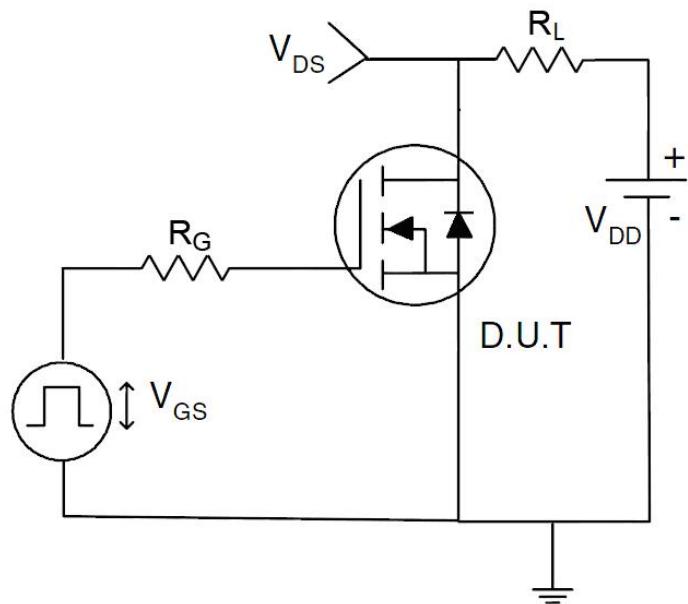
1) E_{AS} test Circuit



2) Gate charge test Circuit



3) Switch Time Test Circuit



Typical Electrical and Thermal Characteristics

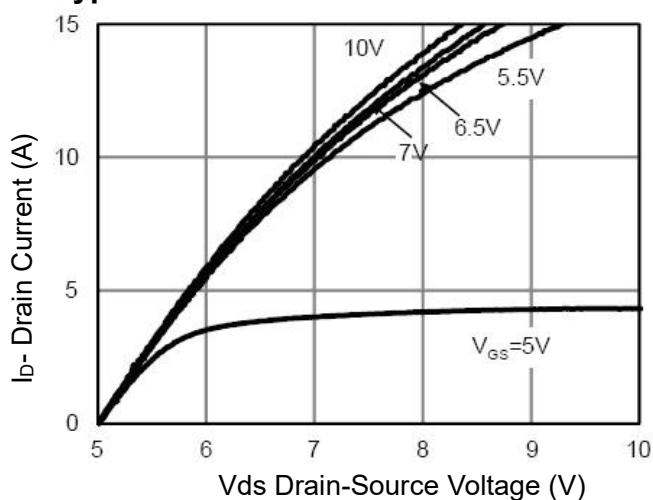


Figure 1 Output Characteristics

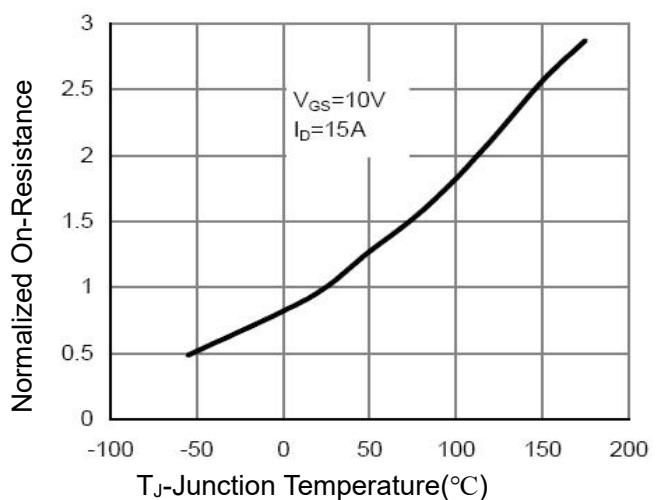


Figure 4 Rdson-Junction Temperature

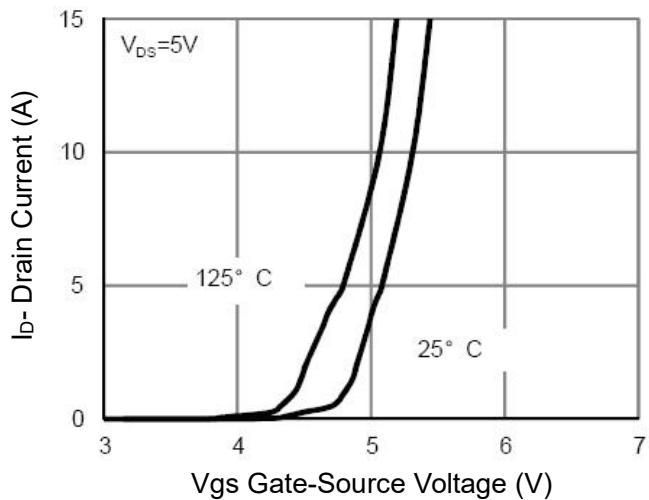


Figure 2 Transfer Characteristics

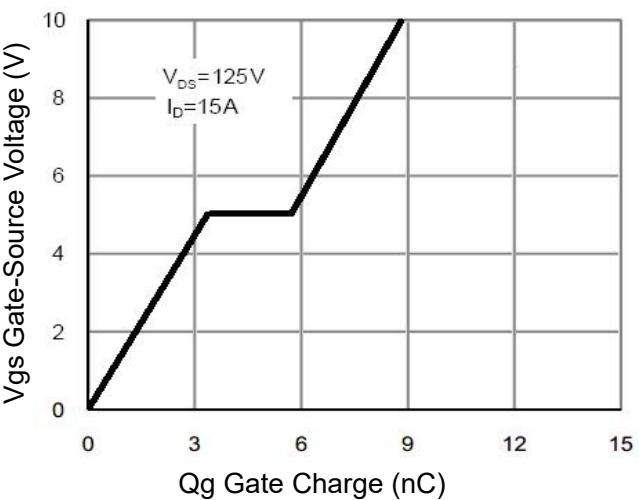


Figure 5 Gate Charge

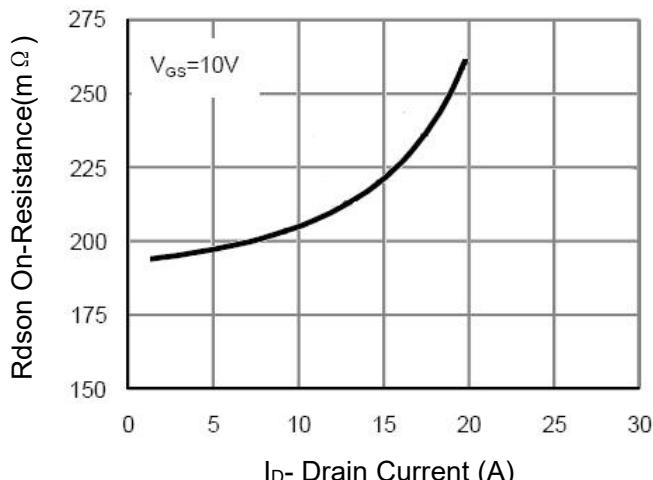


Figure 3 Rdson- Drain Current

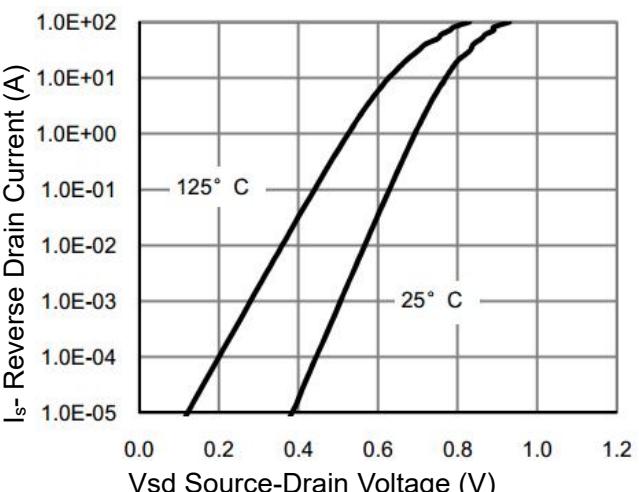


Figure 6 Source- Drain Diode Forward

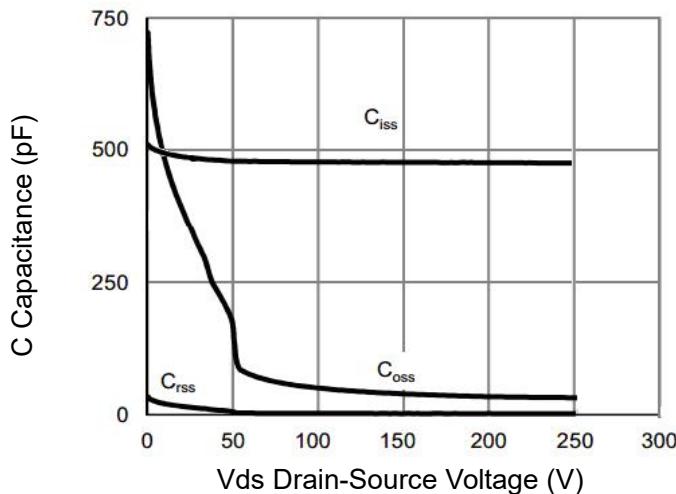


Figure 7 Capacitance vs Vds

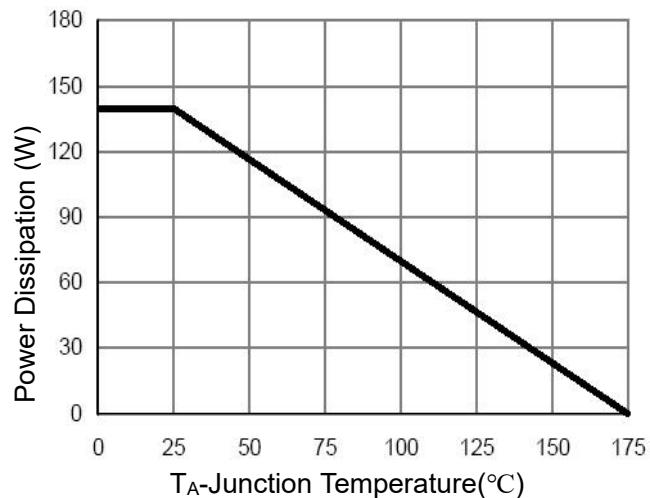


Figure 9 Power De-rating

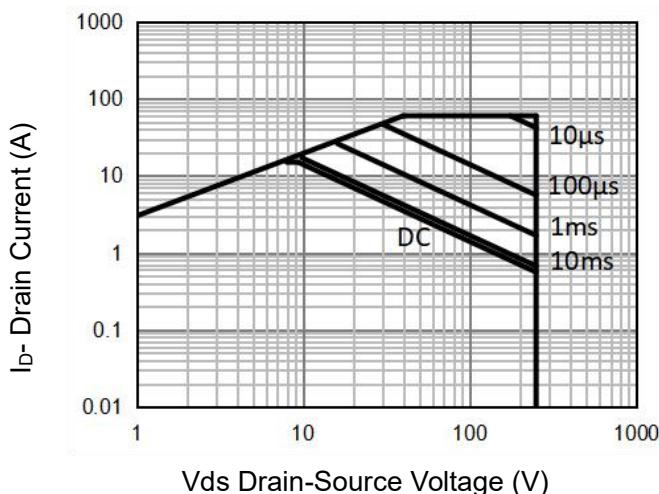


Figure 8 Safe Operation Area (Note 3)

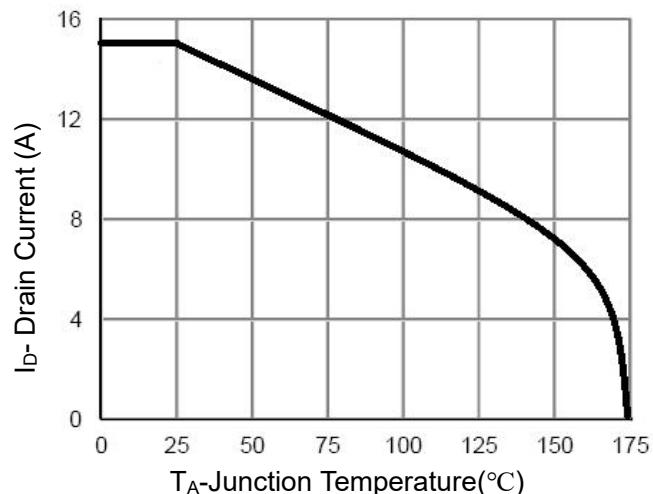


Figure 10 Current De-rating

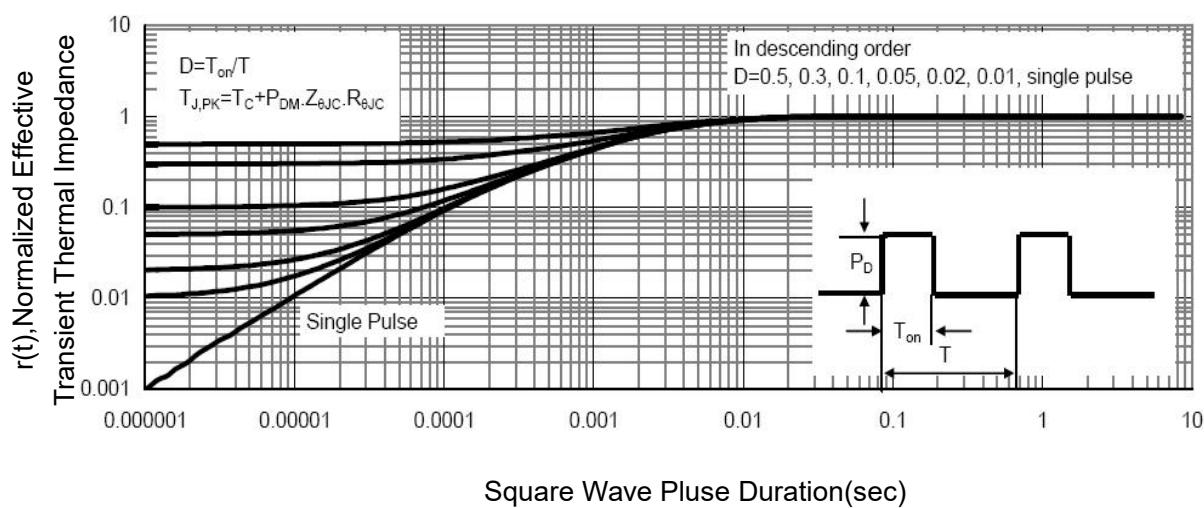
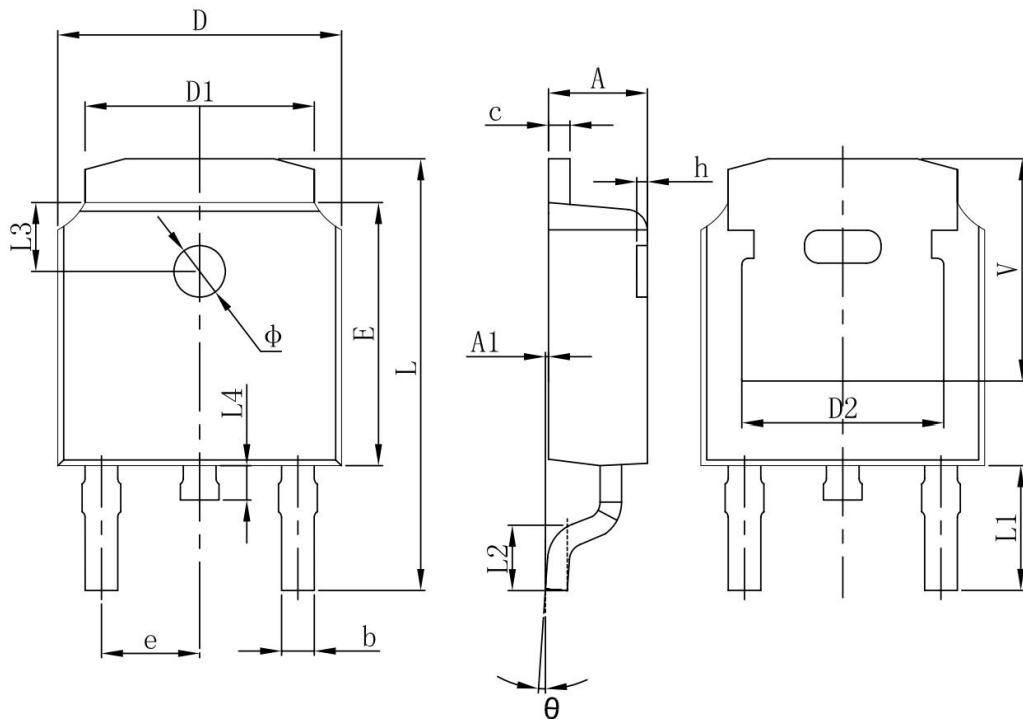


Figure 11 Normalized Maximum Transient Thermal Impedance

TO-252 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.635	0.770	0.025	0.030
c	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.830 REF.		0.190 REF.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.712	10.312	0.382	0.406
L1	2.900 REF.		0.114 REF.	
L2	1.400	1.700	0.055	0.067
L3	1.600 REF.		0.063 REF.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.250 REF.		0.207 REF.	

Attention

QIAOXIN assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all QIAOXIN products described or contained herein. QIAOXIN products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. QIAOXIN reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.